

How Probabilistic Methods for Data Fitting Deal with Interval Uncertainty: A More Realistic Analysis*

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Abstract

In our previous paper, we showed that a simplified probabilistic approach to interval uncertainty leads to the known notion of a united solution set. In this paper, we show that a more realistic probabilistic analysis of data fitting under interval uncertainty leads to another known notion – the notion of a tolerable solution set. Thus, the notion of a tolerance solution set also has a clear probabilistic interpretation. Good news is that, in contrast to the united solution set whose computation is, in general, NP-hard, the tolerable solution set can be computed by a feasible algorithm.

Keywords: Interval uncertainty, united solution set, tolerable solution set, probabilistic uncertainty

AMS subject classifications: 65G20, 65G30, 65G40

1 General motivation

When processing data, most practitioners use probabilistic methods. It is therefore desirable to study how, for the case of interval uncertainty, these methods compare with interval techniques; see, e.g., [1, 5, 6, 7].

2 Data fitting problem

In many situations:

- we know the general form $y = F(x, c)$ of the dependence of a quantity y on quantities $x = (x_1, \dots, x_n)$, but
- we do not know the exact values of the parameters $c = (c_1, \dots, c_m)$.

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Let us have a few example.

- We may have a linear dependence

$$y = c_1 \cdot x_1 + \dots + c_n \cdot x_n + c_{n+1}.$$

- We may have a general quadratic dependence.
- For a radioactive delay, we have a linear combination of exponentially decreasing terms

$$y = \sum_{i=1}^p c_{2i-1} \cdot \exp(-c_{2i} \cdot t),$$

etc.

In all these cases, the values c_i must be determined from the measurement results.

For this purpose, several (K) times, we measure x_i and y . Based on the measurement results $\tilde{x}_k = (\tilde{x}_{k1}, \dots, \tilde{x}_{kn})$ and $\tilde{y}_k$, we need to estimate the values of the parameters that fit the data. This problem is also called *problem of parameter estimation*.

3 Need to take measurement uncertainty into account

Measurements are never absolutely accurate. Because of this, we need to take into account that the measurement results $\tilde{v}$ are, in general, different from the actual (unknown) values of the corresponding quantity v , i.e., that there is a non-zero measurement error $\Delta v := \tilde{v} - v$; see, e.g., [7].

It is important to take the corresponding measurement uncertainty into account when estimating the values of the parameters c_i .

4 Situations when we know the probability distributions

In many cases, we know the probability distributions $f_i(\Delta x_i)$ and $f(\Delta y)$ of the measurement errors, and the measurement errors corresponding to different distributions are independent.

In this case, we can use the Maximum Likelihood (ML) approach; see, e.g., [9]. This means that we select the *most probable* values c (and x_{ki}), i.e., the values for which the corresponding probability – which is equal to the product

$$\prod_{k=1}^K \left(f(\tilde{y}_k - F(x_k, c)) \cdot \prod_{i=1}^n f_i(\tilde{x}_{ki} - x_{ki}) \right),$$

attains its largest possible value.

Usually, instead of maximizing the likelihood, we solve the equivalent problem of maximizing the logarithm of the likelihood – which is known as *log-likelihood*. This reduction often simplifies the computations – e.g., for the Gaussian distribution, logarithm is an easy-to-maximize quadratic function.

5 Interval uncertainty

In many practical situations, we do not know the probability distributions, all we know is that the measurement errors Δv are located on the given interval $[-\Delta_v, \Delta_v]$; see, e.g., [1, 5, 6, 7].

In such situations, a usual probabilistic approach is to select, on this interval, the distribution with maximal entropy. This turns out to be the uniform distribution; see, e.g., [2].

6 Simplest case

The simplest – and rather frequent – case is when the values x_i are measured very accurately. In this case, we can safely ignore the corresponding measurement errors and conclude that $\tilde{x}_{ik} = x_{ik}$ for all i and k . In this case, the ML approach selects the following set:

The set of all possible values c for which, for all k , we have

$$F(x_k, c) \in [\tilde{y}_k - \Delta_y, \tilde{y}_k + \Delta_y].$$

Interestingly, in this case, the probabilistic approach leads to the same answer as the interval techniques – for which this set is called the *united solution set*.

7 General case

In general, we also know the values x_{ki} with interval uncertainty. Then the ML approach selects the following set:

The set of all the values c for which $F(x_k, c) \in \mathbf{y}_k = [\tilde{y}_k - \Delta_y, \tilde{y}_k + \Delta_y]$ for some
values $x_{ki} \in \mathbf{x}_{ki} = [\tilde{x}_{ki} - \Delta_{x_i}, \tilde{x}_{ki} + \Delta_{x_i}]$.

This is also exactly the *united solution set* to the interval equation system constructed from interval data. Thus, the united solution set has a natural probabilistic meaning; see, e.g., [4].

8 A more realistic description of the practical problem

Often, when we get a measurement result, this does not mean that there was only one measurement. It means that there were several different measurements leading to the same result – e.g., same intervals. Let us give a few examples.

- When a patient's blood pressure is measured at the doctor's office, usually, the device performs three measurements and – if they coincide – combines them into a single measurement result.
- This is also how super-precise atomic clocks work – each of them consists of several independent clocks, whose results are returned to the user if most of their readings coincide.

- This is how new values are measured – be it a more accurate value of the distance to the Moon or a new values of an element’s atomic weight. With a single measurement, the result is not fully reliable, so, to make it reliable, several measurements are performed and if they all coincide, the joint result is accepted.

9 How probabilistic techniques deal with this situation

For each k , instead of a single combination x_k , we have several $x_{k\ell}$ for different ℓ . For each combination of values $x_{k\ell i} \in \mathbf{x}_{ki}$, we can form the log-likelihood

$$\sum_{k=1}^K \sum_{\ell} \sum_{i=1}^n \ln(f_i(\tilde{y}_k - F(x_{k\ell}, c))). \quad (1)$$

We do not know the actual values $x_{k\ell i}$. Following the maximum entropy idea, we assume that they are uniformly distributed on the corresponding intervals $\mathbf{x}_{ki}$.

For a reasonably large number of constituent measurement ℓ , the sample average of any quantity – i.e., the arithmetic average over ℓ – is very close to its expected value; see, e.g., [9]. Thus, the sum over ℓ in the formula (1) – which is proportional to the sample average – is proportional to the expected value.

Multiplying the objective function by a proportionality constant does not change the location of its maxima. Thus, maximizing the original expression (1) for the likelihood (1) is equivalent to maximizing the expected value of the log-likelihood

$$\sum_{k=1}^K \sum_{i=1}^n \ln(f_i(\tilde{y}_k - F(x_{k\ell}, c)))$$

over these uniform distributions.

10 What is the resulting estimate

Result. Let us show that, as a result, we return the following set:

The set of all the values c for which $f(x_k, c) \in \mathbf{y}_k$ for all $x_{ki} \in \mathbf{x}_{ki}$.

Proof. Indeed, if the condition $f(x_k, c) \in \mathbf{y}_k$ is not satisfied for some $x_{ki} \in \mathbf{x}_{ki}$, then, for a continuous function $f(x, c)$, there is a whole subrange of the interval $\mathbf{x}_{ki}$ on which this condition is not satisfied. On this subrange, the likelihood will be equal to 0. Thus, on this subrange, the log-likelihood is equal to $\ln(0) = -\infty$; hence, the expected value of log-likelihood is equal to $-\infty$ – so it cannot be the largest. Thus, for all the tuples c selected by the Maximum Likelihood approach, we indeed have $f(x_k, c) \in \mathbf{y}_k$ for all $x_{ki} \in \mathbf{x}_{ki}$.

Since we consider uniform distributions, for each probability distribution, all non-zero values are the same. Thus, for all such tuples c , we will have the exact same values of the expected log-likelihood. So, all such tuples c will be selected by the Maximum Likelihood approach.

This is exactly the tolerable solution set. The above formula is exactly the *tolerable solution set* to the interval equation system constructed from data; see, e.g., [8].

So, the tolerable solution set also makes sense in the probabilistic setting.

Unexpected consequence: a more realistic analysis makes the data fitting problem easier to solve. Good news is that:

- in contrast to the united solution set – whose computation is, in general, NP-hard even when the expression $f(x, c)$ linearly depends on c_i (see, e.g., [3]),
- computation of the tolerable solution set can be, for the case when $f(x, c)$ is linear in c_i , reduced to linear programming and is, thus, feasible; see, e.g., [3, 8].

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